

Search Notes

Application/Control No.

10/817,041

Examiner

Huy D. Nguyen

Applicant(s)/Patent under
Reexamination

CHETIA ET AL.

Art Unit

2681

SEARCHED

Class	Subclass	Date	Examiner
455	456.1	12/5/2005	HN
	456.2		
	456.3		
	456.5		
	456.6		
	440		
	418		
	419		
705	14		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (USPAT, US-PGPUB, EPO, JPO, DERWENT) See search history printout.	12/5/2005	HN